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### DATA SHEET



# MOS INTEGRATED CIRCUITS $\mu$ PD703032A, 703032AY, 70F3032A, 70F3032AY

## V850/SB1<sup>™</sup> 32-BIT SINGLE-CHIP MICROCONTROLLERS

#### DESCRIPTION

The  $\mu$ PD703032A, 703032AY, 70F3032A, and 70F3032AY (V850/SB1) are 32-bit single-chip microcontrollers of the V850 Series<sup>TM</sup> for AV equipment. 32-bit CPU, ROM, RAM, timer/counters, serial interfaces, A/D converter, DMA controller, and so on are integrated on a single chip.

The  $\mu$ PD70F3032A and 70F3032AY have flash memory in place of the internal mask ROM of the  $\mu$ PD703032A and 703032AY. Because flash memory allows the program to be written and erased electrically with the device mounted on the board, these products are ideal for the evaluation stages of system development, small-scale production, and rapid development of new products.

The  $\mu$ PD703031A, 703031AY, 703033A, 703033AY, 70F3033A, 70F3033AY products with a different ROM/RAM size are also available.

Detailed function descriptions are provided in the following user's manuals. Be sure to read them before designing.

V850/SB1, V850/SB2<sup>™</sup> User's Manual Hardware: U13850E V850 Series User's Manual Architecture: U10243E

#### FEATURES

- O Number of instructions: 74
- O Minimum instruction execution time: 50 ns (@ internal 20 MHz operation)
- O General-purpose registers: 32 bits × 32 registers
- O Instruction set: Signed multiplication, saturation operations, 32-bit shift instructions, bit manipulation instructions, load/store instructions
- O Memory space: 16 MB linear address space
- Internal memory ROM: 512 KB (µPD703032A, 703032AY: mask ROM)

512 KB (µPD70F3032A, 70F3032AY: flash memory)

#### RAM: 24 KB (µPD703032A, 703032AY, 70F3032A, 70F3032AY)

O Interrupt/exception: µPD703032A, 70F3032A (external: 8, internal: 31 sources, exception: 1 source)

µPD703032AY, 70F3032AY (external: 8, internal: 32 sources, exception: 1 source)

- O I/O lines Total: 83
- O Timer/counters: 16-bit timer (2 channels: TM0, TM1)

8-bit timer (6 channels: TM2 to TM7)

- O Watch timer: 1 channel
- O Watchdog timer: 1 channel

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- NEC
- O Serial interface
  - Asynchronous serial interface (UART0, UART1)
  - Clocked serial interface (CSI0 to CSI3)
  - 3-wire variable length serial interface (CSI4)
  - I<sup>2</sup>C bus interface (I<sup>2</sup>C0, I<sup>2</sup>C1) (μPD703032AY, 70F3032AY only)
- O 10-bit resolution A/D converter: 12 channels
- O DMA controller: 6 channels
- O Real-time output port: 8 bits  $\times$  1 channel or 4 bits  $\times$  2 channels
- O ROM correction: 4 places can be corrected
- O Power-saving function: HALT/IDLE/STOP modes
- O Packages: 100-pin plastic QFP (14  $\times$  20)
- Ο μPD70F3032A, 70F3032AY
  - $\bullet$  Can be replaced with  $\mu \text{PD703032A}$  and 703032AY (internal mask ROM) in mass production

#### **APPLICATIONS**

O AV equipment (audio, car audio, VCR, TV, etc.)

#### **ORDERING INFORMATION**

	Part Number	Package	Internal ROM
	μPD703032AGF- <b>xxx</b> -3BA	100-pin plastic QFP (14 $ imes$ 20)	Mask ROM (512 KB)
	μPD703032AYGF-xxx-3BA	100-pin plastic QFP (14 $ imes$ 20)	Mask ROM (512 KB)
$\star$	μPD70F3032AGF-3BA	100-pin plastic QFP (14 $ imes$ 20)	Flash memory (512 KB)
$\star$	$\mu$ PD70F3032AYGF-3BA	100-pin plastic QFP (14 $ imes$ 20)	Flash memory (512 KB)

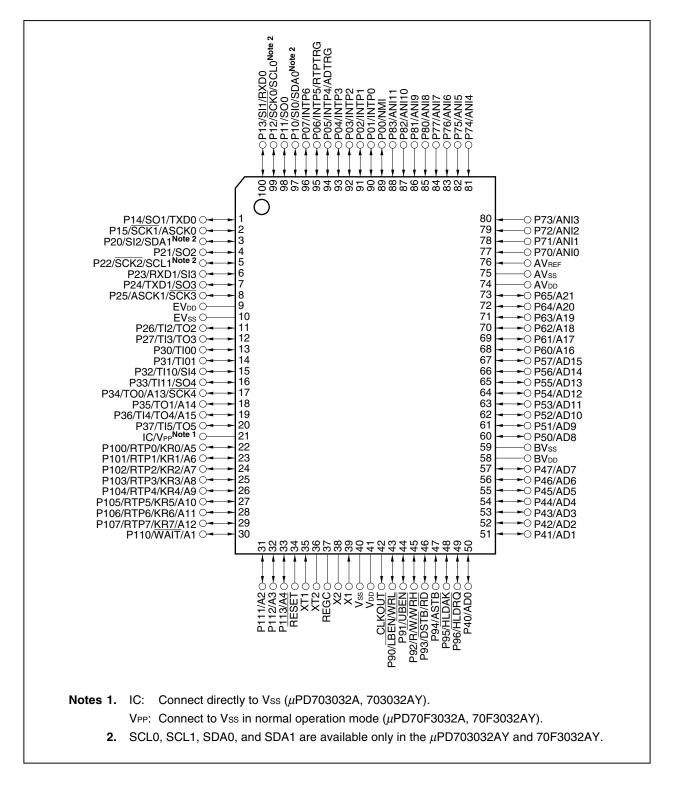
**Remarks 1.** ××× indicates ROM code suffix.

2. ROMless versions are not provided.

#### **PIN CONFIGURATION (Top View)**

#### 100-pin plastic QFP (14 × 20)

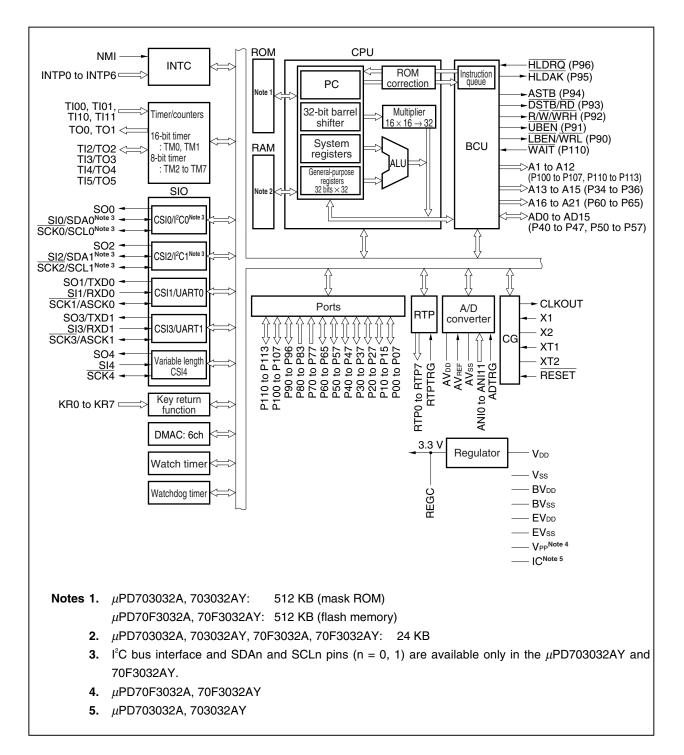
- µPD703032AGF-×××-3BA
- µPD703032AYGF-×××-3BA
- μPD70F3032AGF-3BA
- *μ*PD70F3032AYGF-3BA



#### PIN IDENTIFICATION

A1 to A21:	Address Bus	P80 to P83:	Port 8
AD0 to AD15:	Address/Data Bus	P90 to P96:	Port 9
ADTRG:	A/D Trigger Input	P100 to P107:	Port 10
ANI0 to ANI11:	Analog Input	P110 to P113:	Port 11
ASCK0, ASCK1:	Asynchronous Serial Clock	RD:	Read
ASTB:	Address Strobe	REGC:	Regulator Control
AVDD:	Analog Power Supply	RESET:	Reset
AVREF:	Analog Reference Voltage	RTP0 to RTP7:	Real-time Output Port
AVss:	Analog Ground	RTPTRG:	RTP Trigger Input
BVDD:	Power Supply for Bus Interface	R/W:	Read/Write Status
BVss:	Ground for Bus Interface	RXD0, RXD1:	Receive Data
CLKOUT:	Clock Output	SCK0 to SCK4:	Serial Clock
DSTB:	Data Strobe	SCL0, SCL1:	Serial Clock
EVDD:	Power Supply for Port	SDA0, SDA1:	Serial Data
EVss:	Ground for Port	SI0 to SI4:	Serial Input
HLDAK:	Hold Acknowledge	SO0 to SO4:	Serial Output
HLDRQ:	Hold Request	TI00, TI01, TI10, :	Timer Input
IC:	Internally Connected	TI11, TI2 to TI5	
INTP0 to INTP6:	Interrupt Request from Peripherals	TO0 to TO5:	Timer Output
KR0 to KR7:	Key Return	TXD0, TXD1:	Transmit Data
LBEN:	Lower Byte Enable	UBEN:	Upper Byte Enable
NMI:	Non-Maskable Interrupt Request	VDD:	Power Supply
P00 to P07:	Port 0	VPP:	Programming Power Supply
P10 to P15:	Port 1	Vss:	Ground
P20 to P27:	Port 2	WAIT:	Wait
P30 to P37:	Port 3	WRH:	Write Strobe High Level Data
P40 to P47:	Port 4	WRL:	Write Strobe Low Level Data
P50 to P57:	Port 5	X1, X2:	Crystal for Main Clock
P60 to P65:	Port 6	XT1, XT2:	Crystal for Sub-clock
P70 to P77:	Port 7		

#### INTERNAL BLOCK DIAGRAM



#### CONTENTS

1.	DIFFERENCES AMONG PRODUCTS	7
2.	PIN FUNCTIONS	
	2.1 Port Pins	8
	2.2 Non-Port Pins	
	2.3 Pin I/O Circuits and Recommended Connection of Unused Pins	14
3.	ELECTRICAL SPECIFICATIONS	-
	3.1 Flash Memory Programming Mode (μPD70F3032A, 70F3032AY only)	42
4.	PACKAGE DRAWING	43
5.	RECOMMENDED SOLDERING CONDITIONS	44
★AP	PENDIX NOTES ON TARGET SYSTEM DESIGN	46

Product Name	Incorporated	RON	N	RAM Size	Flash Memory	Package
	I <sup>2</sup> C	Туре	Size		Programming Pin	
μPD703031A	No	Mask ROM	128 KB	12 KB	No	100-pin QFP (14 $ imes$ 20)
μPD703031AY	Yes					100-pin LQFP (14 × 14)
µPD703033A	No	Mask ROM	256 KB	16 KB	No	100-pin QFP (14 $ imes$ 20)
μPD703033AY	Yes					100-pin LQFP (14 × 14)
µPD70F3033A	No	Flash memory			Yes (VPP)	
μPD70F3033AY	Yes					
µPD703032A	No	Mask ROM	512 KB	24 KB	No	100-pin QFP (14 $ imes$ 20)
μPD703032AY	Yes					
µPD70F3032A	No	Flash memory			Yes (VPP)	
μPD70F3032AY	Yes					

#### **1. DIFFERENCES AMONG PRODUCTS**

- Cautions 1. There are differences in noise immunity and noise radiation between the flash memory and mask ROM versions. When pre-producing an application set with the flash memory version and then mass-producing it with the mask ROM version, be sure to conduct sufficient evaluations for the commercial samples (not engineering samples) of the mask ROM version.
  - 2. When replacing the flash memory versions with mask ROM versions, write the same code in the empty area of the internal ROM.

#### 2. PIN FUNCTIONS

#### 2.1 Port Pins

Pin Name	I/O	PULL	Function	Alternate Function	
P00	I/O	Yes	Port 0	NMI	
P01			Port 0         8-bit I/O port         Input/output can be specified in 1-bit units.         Port 1         6-bit I/O port         Input/output can be specified in 1-bit units.         Port 2         8-bit I/O port         Input/output can be specified in 1-bit units.	INTPO	
P02	-			INTP1	
P03	-			INTP2	
P04				INTP3	
P05				INTP4/ADTRG	
P06				INTP5/RTPTRG	
P07				INTP6	
P10	I/O	Yes	Port 1	SI0/SDA0 <sup>Note</sup>	
P11				SO0	
P12			Input/output can be specified in 1-bit units.	SCK0/SCL0 <sup>Note</sup>	
P13				SI1/RXD0	
P14				SO1/TXD0	
P15				SCK1/ASCK0	
P20	I/O	Yes	Port 2	SI2/SDA1 <sup>Note</sup>	
P21		٤			SO2
P22				inpuvouput can be specified in 1-bit units.	SCK2/SCL1 <sup>Note</sup>
P23				SI3/RXD1	
P24				SO3/TXD1	
P25				SCK3/ASCK1	
P26				TI2/TO2	
P27				ТІЗ/ТОЗ	
P30	I/O	Yes		T100	
P31				TI01	
P32			inpuvouput can be specified in 1-bit units.	TI10/SI4	
P33				TI11/SO4	
P34				TO0/A13/SCK4	
P35				TO1/A14	
P36				TI4/TO4/A15	
P37				TI5/TO5	
P40 to P47	I/O	No	8-bit I/O port	AD0 to AD7	
P50 to P57	I/O	No	8-bit I/O port	AD8 to AD15	

Note  $\mu$ PD703032AY, 70F3032AY only.

			1	(2/2	
Pin Name	I/O	PULL	Function	Alternate Function	
P60 to P65	I/O	No	Port 6 6-bit I/O port Input/output can be specified in 1-bit units.	A16 to A21	
P70 to P77	Input	No	Port 7 8-bit input port	ANI0 to ANI7	
P80 to P83	Input	No	Port 8 4-bit input port	ANI8 to ANI11	
P90	I/O	No	Port 9	LBEN/WRL	
P91			7-bit I/O port	UBEN	
P92	1		Input/output can be specified in 1-bit units.	R/W/WRH	
P93	1			DSTB/RD	
P94	1			ASTB	
P95					HLDAK
P96				HLDRQ	
P100	I/O	Yes	Port 10	RTP0/A5/KR0	
P101			8-bit I/O port Input/output can be specified in 1-bit units.	RTP1/A6/KR1	
P102			inpuroulput can be specified in 1-bit units.	RTP2/A7/KR2	
P103				RTP3/A8/KR3	
P104				RTP4/A9/KR4	
P105				RTP5/A10/KR5	
P106					RTP6/A11/KR6
P107				RTP7/A12/KR7	
P110	I/O	Yes	Port 11	A1/WAIT	
P111	]		4-bit I/O port	A2	
P112			Input/output can be specified in 1-bit units.	A3	
P113	]			A4	

#### 2.2 Non-Port Pins

Pin Name	I/O	PULL	Function	Alternate Function
A1	Output	Yes	Lower address bus used for external memory expansion	P110/WAIT
A2	-			P111
A3	-			P112
A4				P113
A5				P100/RTP0/KR0
A6				P101/RTP1/KR1
A7				P102/RTP2/KR2
A8				P103/RTP3/KR3
A9				P104/RTP4/KR4
A10				P105/RTP5/KR5
A11				P106/RTP6/KR6
A12				P107/RTP7/KR7
A13				P34/TO0/SCK4
A14				P35/TO1
A15				P36/TO4/TI4
A16 to A21	Output	No	Higher address bus used for external memory expansion	P60 to P65
AD0 to AD7	I/O	No	16-bit multiplexed address/data bus used for external memory	P40 to P47
AD8 to AD15			expansion	P50 to P57
ADTRG	Input	Yes	A/D converter external trigger input	P05/INTP4
ANI0 to ANI7	Input	No	Analog input to A/D converter	P70 to P77
ANI8 to ANI11				P80 to P83
ASCK0	Input	Yes	Baud rate clock input for UART0	P15/SCK1
ASCK1			Baud rate clock input for UART1	P25/SCK3
ASTB	Output	No	External address strobe output	P94
AVdd	-	-	Positive power supply for A/D converter and alternate port	-
AVREF	Input	-	Reference voltage input for A/D converter	_
AVss	-	-	Ground potential for A/D converter and alternate port	-
BVDD	-	_	Positive power supply for bus interface and alternate port	-
BVss	-	_	Ground potential for bus interface and alternate port	-
CLKOUT	Output	-	Internal system clock output	-
DSTB	Output	No	External data strobe output	P93/RD
EVDD	-	-	Positive power supply for I/O ports and alternate-function pins (except bus interface alternate port)	-
EVss	_	_	Ground potential for I/O ports and alternate-function pins (except bus interface alternate port)	-
HLDAK	Output	No	Bus hold acknowledge output	P95
HLDRQ	Input	No	Bus hold request input	P96
IC	_	_	Internally connected (µPD703032A, 703032AY only)	_

Pin Name	I/O	PULL	Function	Alternate Function
INTP0	Input	Yes	External interrupt request input (analog noise elimination)	P01
INTP1	_			P02
INTP2				P03
INTP3				P04
INTP4	Input	Yes	External interrupt request input (digital noise elimination)	P05/ADTRG
INTP5				P06/RTPTRG
INTP6	Input	Yes	External interrupt request input (digital noise elimination supporting remote controller)	P07
KR0	Input	Yes	Key return input	P100/RTP0/A5
KR1				P101/RTP1/A6
KR2				P102/RTP2/A7
KR3				P103/RTP3/A8
KR4				P104/RTP4/A9
KR5				P105/RTP5/A10
KR6				P106/RTP6/A11
KR7				P107/RTP7/A12
LBEN	Output	No	External data bus's lower byte enable output	P90/WRL
NMI	Input	Yes	Non-maskable interrupt request input	P00
RD	Output	No	Read strobe output	P93/DSTB
REGC	-	-	Regulator output stabilization capacitance connection	-
RESET	Input	-	System reset input	-
RTP0	Output	Yes	Real-time output port	P100/KR0/A5
RTP1				P101/KR1/A6
RTP2				P102/KR2/A7
RTP3				P103/KR3/A8
RTP4				P104/KR4/A9
RTP5				P105/KR5/A10
RTP6				P106/KR6/A11
RTP7				P107/KR7/A12
RTPTRG	Input	Yes	Real-time output port external trigger input	P06/INTP5
R/W	Output	No	External read/write status output	P92/WRH
RXD0	Input	Yes	Serial receive data input for UART0 and UART1	P13/SI1
RXD1	1			P23/SI3

Pin Name	I/O	PULL	Function	(3/4 Alternate Function
SCK0	I/O	Yes	Serial clock I/O (3-wire type) for CSI0 to CSI3	P12/SCL0 <sup>Note</sup>
SCK1				P15/ASCK0
SCK2				P22/SCL1 <sup>Note</sup>
SCK3				P25/ASCK1
SCK4	I/O	Yes	Serial clock I/O (3-wire type) for variable length CSI4	P34/TO0/A13
SCL0	I/O	Yes	Serial clock I/O for I <sup>2</sup> C0 and I <sup>2</sup> C1	P12/SCK0
SCL1			(µPD703032AY, 70F3032AY only)	P22/SCK2
SDA0	I/O	Yes	Serial transmit/receive data I/O for I <sup>2</sup> C0 and I <sup>2</sup> C1	P10/SI0
SDA1			(µPD703032AY, 70F3032AY only)	P20/SI2
SIO	Input	Yes	Serial receive data input (3-wire type) for CSI0 to CSI3	P10/SDA0 <sup>Note</sup>
SI1				P13/RXD0
SI2				P20/SDA1 <sup>Note</sup>
SI3				P23/RXD1
SI4	Input	Yes	Serial receive data input (3-wire type) for variable length CSI4	P32/TI10
SO0	Output	Yes	Serial transmit data output (3-wire type) for CSI0 to CSI3	P11
SO1				P14/TXD0
SO2				P21
SO3				P24/TXD1
SO4	Output	Yes	Serial transmit data output (3-wire type) for variable length CSI4	P33/TI11
T100	Input	Yes	External count clock input for TM0/external capture trigger input for TM0	P30
TI01			External capture trigger input for TM0	P31
TI10			External count clock input for TM1/external capture trigger input for TM1	P32/SI4
TI11			External capture trigger input for TM1	P33/SO4
TI2	Input	Yes	External count clock input for TM2 to TM5	P26/TO2
TI3				P27/TO3
TI4				P36/TO4/A15
TI5				P37/TO5
TO0	Output	Yes	Pulse signal output for TM0 and TM1	P34/A13/SCK4
TO1				P35/A14
TO2	Output	Yes	Pulse signal output for TM2 to TM5	P26/TI2
TO3				P27/TI3
TO4				P36/TI4/A15
TO5				P37/TI5
TXD0	Output	Yes	Serial transmit data output for UART0 and UART1	P14/SO1
TXD1				P24/SO3
UBEN	Output	No	Higher byte enable output for external data bus	P91
VDD	_	_	Positive power supply pin	_

**Note** *μ*PD703032AY, 70F3032AY only.

(4/4)

Pin Name	I/O	PULL	Function	Alternate Function
Vpp	-	-	High voltage apply pin for program write/verify (μPD70F3032A, 70F3032AY only)	-
Vss	-	_	Ground potential	-
WAIT	Input	Yes	Control signal input for inserting wait in bus cycle	P110/A1
WRH	Output	No	Higher byte write strobe signal output for external data bus	P92/R/W
WRL	Output	No	Lower byte write strobe signal output for external data bus	P90/LBEN
X1	Input	No	Resonator connection for main clock	-
X2	-			-
XT1	Input	No	Resonator connection for subsystem clock	-
XT2	-			-

#### 2.3 Pin I/O Circuits and Recommended Connection of Unused Pins

The input/output circuit type of each pin and recommended connection of unused pins are show in Table 2-1. For the input/output schematic circuit diagram of each type, refer to Figure 2-1.

Pin	Alternate Function	I/O Circuit Type	I/O Buffer Power Supply	Recommended Connection of Unused Pins
P00	NMI	8-A	EVDD	Input state: Independently connect to EVDD or
P01	INTP0			EVss via a resistor. Output state: Leave open.
P02	INTP1			
P03	INTP2			
P04	INTP3			
P05	INTP4/ADTRG			
P06	INTP5/RTPTRG			
P07	INTP6			
P10	SI0/SDA0	10-A	EVDD	Input state: Independently connect to EVDD or
P11	SO0	26		EVss via a resistor. Output state: Leave open.
P12	SCK0/SCL0	10-A		Supur sidie. Leave open.
P13	SI1/RXD0	8-A		
P14	SO1/TXD0	26		
P15	SCK1/ASCK0	10-A		
P20	SI2/SDA1	10-A	EVDD	Input state: Independently connect to EVDD or
P21	SO2	26		EVss via a resistor. Output state: Leave open.
P22	SCK2/SCL1	10-A 8-A		
P23	SI3/RXD1			
P24	SO3/TXD1	26		
P25	SCK3/ASCK1	10-A		
P26	TI2/TO2	8-A		
P27	TI3/TO3			
P30	T100	8-A	EVDD	Input state: Independently connect to EVDD or
P31	TI01			EVss via a resistor. Output state: Leave open.
P32	TI10/SI4			
P33	TI11/SO4			
P34	TO0/A13/SCK4			
P35	TO1/A14	5-A		
P36	TI4/TO4/A15	8-A		
P37	TI5/TO5			
P40 to P47	AD0 to AD7	5	BVDD	Input state: Independently connect to BVDD or BVSS via a resistor.
P50 to P57	AD8 to AD15	5	BVDD	Output state: Leave open.
P60 to P65	A16 to A21	5	BVDD	

Table 2-1	Types of Pin I	O Circuits and	Recommended	<b>Connection of</b>	<b>Unused Pins (</b>	1/2)
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★ ★

Pin	Alternate Function	I/O Circuit Type	I/O Buffer Power Supply	Recommended Connection of Unused Pins
P70 to P77	ANI0 to ANI7	9	AVDD	Independently connect to AVDD or AVSS via a resistor.
P80 to P83	ANI8 to ANI11	9	AVDD	
P90	LBEN/WRL	5	BVDD	Input state: Independently connect to BVDD or
P91	UBEN			BVss via a resistor.
P92	R/W/WRH			Output state: Leave open.
P93	DSTB/RD	1		
P94	ASTB			
P95	HLDAK	1		
P96	HLDRQ			
P100	RTP0/A5/KR0	10-A	EVDD	Input state: Independently connect to EVDD or
P101	RTP1/A6/KR1			EVss via a resistor.
P102	RTP2/A7/KR2			Output state: Leave open.
P103	RTP3/A8/KR3			
P104	RTP4/A9/KR4			
P105	RTP5/A10/KR5			
P106	RTP6/A11/KR6			
P107	RTP7/A12/KR7			
P110	A1/WAIT	5-A	EVDD	Input state: Independently connect to EVDD or
P111	A2			EVss via a resistor.
P112	A3			Output state: Leave open.
P113	A4			
CLKOUT	_	4	BVDD	Leave open.
RESET	-	2	EVDD	_
XT1	_	16	-	Connect to Vss via a resistor.
XT2	-	16	-	Leave open.
AVREF	-	-	-	Connect to AVss via a resistor.
IC <sup>Note 1</sup>	-	-	-	Connect directly to Vss.
VPP <sup>Note 2</sup>	-	_	-	Connect to Vss.

**Notes 1.** *μ*PD703032A, 703032AY

**2.** μPD70F3032A, 70F3032AY

Caution Three power supply systems are available to supply power to the I/O buffers of the V850/SB1's pins: EVDD, BVDD, and AVDD. The voltage ranges that can be used for these I/O buffer power supplies are shown below.

EVDD, BVDD: 3.0 to 5.5 V AVDD: 4.5 to 5.5 V

The electrical specifications differ depending on whether the power supply voltage range is 3.0 to under 4.0 V, or 4.0 to 5.5 V.

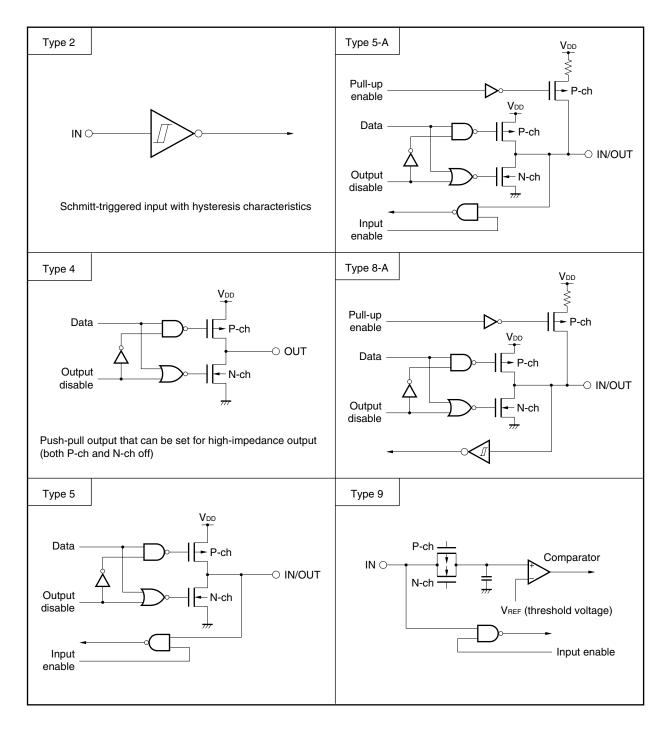


Figure 2-1. Pin Input/Output Circuits (1/2)

Caution VDD in the circuit diagrams can be read as EVDD, BVDD, or AVDD, as appropriate.

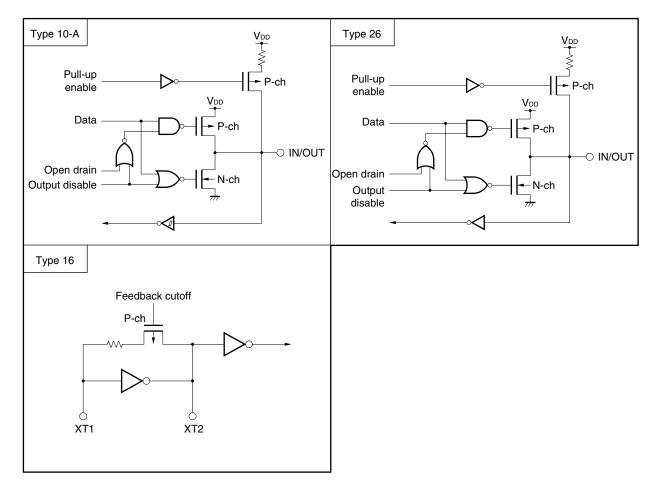


Figure 2-1. Pin Input/Output Circuits (2/2)

Caution VDD in the circuit diagrams can be read as EVDD, BVDD, or AVDD, as appropriate.

#### 3. ELECTRICAL SPECIFICATIONS

#### Absolute Maximum Ratings (T<sub>A</sub> = 25 °C, Vss = 0 V)

Parameter	Symbol	Conditions	Ratings	Unit
Supply voltage	VDD	Vod pin	–0.5 to +7.0	V
*	Vpp	V <sub>PP</sub> pin (μPD70F3032A, 70F3032AY only)	-0.5 to +8.5	V
	AVDD	AV₀₀ pin	–0.5 to +7.0	v
	BVDD	BV <sub>DD</sub> pin	-0.5 to +7.0	v
	EVDD	EV₀₀ pin	-0.5 to +7.0	v
	AVss	AVss pin	–0.5 to +0.5	V
	BVss	BVss pin	–0.5 to +0.5	V
	EVss	EVss pin	–0.5 to +0.5	V
★ Input voltage	VII	Note 1 (BV <sub>DD</sub> pin)	-0.5 to BV <sub>DD</sub> + 0.5 <sup>Note 4</sup>	V
	Vı2	Note 2, RESET (EV₀₀ pin)	-0.5 to EV <sub>DD</sub> + 0.5 <sup>Note 4</sup>	V
Analog input voltage	VIAN	Note 3 (AVDD pin)	-0.5 to AV <sub>DD</sub> + 0.5 <sup>Note 4</sup>	V
Analog reference input voltage	AVREF	AV <sub>REF</sub> pin	-0.5 to AV <sub>DD</sub> + 0.5 <sup>Note 4</sup>	V
Output current, low	lol	Per pin	4.0	mA
		Total for P00 to P07, P10 to P15, P20 to P25	25	mA
		Total for P26, P27, P30 to P37, P100 to P107, P110 to P113	25	mA
		Total for P40 to P47, P90 to P96, CLKOUT	25	mA
		Total for P50 to P57, P60 to P65	25	mA
Output current, high	Іон	Per pin	-4.0	mA
		Total for P00 to P07, P10 to P15, P20 to P25	-25	mA
		Total for P26, P27, P30 to P37, P100 to P107, P110 to P113	-25	mA
		Total for P40 to P47, P90 to P96, CLKOUT	-25	mA
		Total for P50 to P57, P60 to P65	-25	mA
Output voltage	V <sub>01</sub>	Note 1, CLKOUT (BVDD pin)	-0.5 to BV <sub>DD</sub> + 0.5 <sup>Note 4</sup>	V
*	V <sub>O2</sub>	Note 2 (EV <sub>DD</sub> pin)	-0.5 to EV <sub>DD</sub> + 0.5 <sup>Note 4</sup>	V
Operating ambient temperature	TA	Normal operation mode	-40 to +85	°C
*		Flash memory programming mode (μPD70F3032A, 70F3032AY only)	-20 to +85	°C
Storage temperature	Tstg	μPD703032A, 703032AY	-65 to +150	°C
		μPD70F3032A, 70F3032AY	-40 to +125	°C

Notes 1. Ports 4, 5, 6, 9, and their alternate-function pins

- 2. Ports 0, 1, 2, 3, 10, 11, and their alternate-function pins
- 3. Ports 7, 8, and their alternate-function pins
- 4. Be sure not to exceed the absolute maximum ratings (MAX. value) of each supply voltage.

- Cautions 1. Do not directly connect the output (or I/O) pins of IC products to each other, or to VDD, Vcc, and GND. Open-drain pins or open-collector pins, however, can be directly connected to each other. Direct connection of the output pins between an IC product and an external circuit is possible, if the output pins can be set to the high-impedance state and the output timing of the external circuit is designed to avoid output conflict.
  - 2. Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

The ratings and conditions indicated for DC characteristics and AC characteristics represent the quality assurance range during normal operation.

#### Capacitance (TA = 25 °C, VDD = AVDD = BVDD = EVDD = VSS = AVSS = BVSS = EVSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input capacitance	Cı	fc = 1 MHz			15	pF
I/O capacitance	Сю	Unmeasured pins returned to 0 V			15	pF
Output capacitance	Co				15	pF

#### **Operating Conditions**

#### ★ (1) Operating frequency

Operat	Operating Frequency (fxx)		AVDD		BVDD	EVDD	Remark
			Note 1	Note 2			
2 to 20 MHz		4.0 to 5.5 V	4.5 to 5.5 V	4.0 to 5.5 V	4.0 to 5.5 V	4.0 to 5.5 V	Note 3
2 to 17 MHz		4.0 to 5.5 V	4.5 to 5.5 V	4.0 to 5.5 V	3.0 to 5.5 V	3.0 to 5.5 V	
32.768 kHz	Other than IDLE mode	4.0 to 5.5 V	4.5 to 5.5 V	4.0 to 5.5 V	3.0 to 5.5 V	3.0 to 5.5 V	_
	IDLE mode	3.5 to 5.5 V	-	4.0 to 5.5 V	3.0 to 5.5 V	3.0 to 5.5 V	Note 4

#### Notes 1. When A/D converter is used

- 2. When A/D converter is not used
- **3.** During STOP mode (when only watch timer is operating), V<sub>DD</sub> = 3.5 to 5.5 V. Shifting to STOP mode or restoring from STOP mode must be performed at V<sub>DD</sub> = 4.0 V min.
- 4. Shifting to IDLE mode or restoring from IDLE mode must be performed at  $V_{DD} = 4.0 V$  min.

#### (2) CPU operating frequency

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
CPU operating frequency	fсрu	Main clock operation	0.25		20	MHz
		Subclock operation		32.768		kHz

#### **Recommended Oscillator**

(1) Main clock oscillator (T<sub>A</sub> = -40 to +85 °C)

#### (a) Connection of ceramic resonator or crystal resonator

		X1   X2   Here   Rd   Rd   Rd   Rd   Rd   Rd   Rd   R				
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Oscillation frequency	fxx		2		20	MHz
Oscillation stabilization time	-	Upon reset release		2 <sup>19</sup> /fxx		s
	-	Upon STOP mode release		Note		s
<b>Note</b> The TYP. value dif	ers aepenai	ing on the setting of the oscillation stabi	lization ti	me selec	t register	(OSTS)

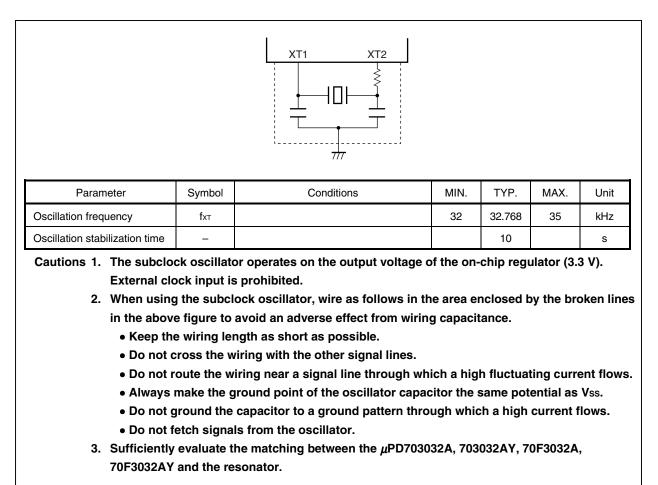
#### (b) Ceramic resonator ( $T_A = -40$ to +85 °C)

Manufacturer	Part Number	Oscillation Frequency	Rec	Recommended Circuit Constant				Oscillation Voltage Range		
		fxx (MHz)	C1 (pF)	C2 (pF)	Rf (kΩ)	Rd (k $\Omega$ )	MIN. (V)	MAX. (V)		
Murata Mfg.	CSTLS8M00G56-B0	8.00	On-chip	On-chip	_	0	4.0	5.5		
Co., Ltd.	CSTCC8M00G56-R0		On-chip	On-chip	_	0	4.0	5.5		
	CSTLA12M5T55-B0	CSTLA12M5T55-B0 12.5	12.5	On-chip	On-chip	_	0	4.0	5.5	
	CSTCV12M5T54J-R0		On-chip	On-chip	-	0	4.0	5.5		
	CSALS16M0X55-B0	16.00	10	10	_	0	4.0	5.5		
	CSTCV16M0X51J-R0		On-chip	On-chip	_	0	4.0	5.5		
	CSTLS20M0X51-B0	20.00	On-chip	On-chip	-	0	4.0	5.5		
	CSTCW20M0X51-R0		On-chip	On-chip	22	0	4.0	5.5		

Caution The oscillator constant and oscillation voltage range indicate conditions of stable oscillation. Oscillation frequency precision is not guaranteed. For applications requiring oscillation frequency precision, the oscillation frequency must be adjusted on the implementation circuit. For details, please contact directly the manufacturer of the resonator you will use.

#### (2) Subclock oscillator (T<sub>A</sub> = -40 to +85 °C)

#### (a) Connection of crystal resonator



DC Characteristics (TA = -40 to +85 °C, VDD = 4.0 to 5.5 V, BVDD = EVDD = 3.0 to 5.5 V,

AV<sub>DD</sub> = 4.5 to 5.5 V (when A/D converter is used),

AVDD = 4.0 to 5.5 V (when A/D converter is not used), Vss = AVss = BVss = EVss = 0 V) (1/2)

Parameter	Symbol	Co	onditions	MIN.	TYP.	MAX.	Uni
Input voltage, high	VIH1	Note 1	$4.0~V \leq BV_{\text{DD}} \leq 5.5~V$	0.7BVDD		BVDD	V
			$3.0 \text{ V} \le BV_{\text{DD}} < 4.0 \text{ V}$	0.8BVDD		BVDD	V
	VIH2	Note 2	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	0.7EV <sub>DD</sub>		EVDD	V
			$3.0~V \leq EV_{\text{DD}} < 4.0~V$	0.8EVDD		EVDD	V
	Vінз	Note 3, RESET	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	0.7EV <sub>DD</sub>		EVDD	V
			$3.0 \text{ V} \leq \text{EV}_{\text{DD}} < 4.0 \text{ V}$	0.8EVDD		EVDD	V
	VIH4	Note 4		0.7AVDD		AVDD	V
Input voltage, low	VIL1	Note 1		BVss		0.3BVDD	V
	VIL2	Note 2		EVss		0.3EVDD	V
	VIL3	Note 3, RESET		EVss		0.3EVDD	V
	VIL4	Note 4		AVss		0.3AVDD	V
Output voltage, high	Voh1	Note 1, CLKOUT	$3.0 \text{ V} \le \text{BV}_{\text{DD}} \le 5.5 \text{ V},$ Іон = -100 $\mu$ A	BV <sub>DD</sub> – 0.5			V
			$4.0 \text{ V} \leq \text{BV}_{\text{DD}} \leq 5.5 \text{ V},$ $\text{I}_{\text{OH}} = -3 \text{ mA}$	BV <sub>DD</sub> - 1.0			V
	Vон2	Notes 2, 3	$3.0 \text{ V} \le \text{EV}_{\text{DD}} \le 5.5 \text{ V},$ Іон = -100 $\mu$ А	EV <sub>DD</sub> - 0.5			V
			$4.0 \text{ V} \leq \text{EV}_{\text{DD}} \leq 5.5 \text{ V},$ $I_{\text{OH}} = -3 \text{ mA}$	EV <sub>DD</sub> - 1.0			V
Output voltage, low	Vol	Io∟ = 3 mA, 3.0 V ≤ BV <sub>DD</sub> , EV <sub>D</sub>	<sup>D</sup> ≤ 5.5 V			0.5	V
		$I_{OL} = 3 \text{ mA},$ 4.0 V $\leq$ BV <sub>DD</sub> , EV <sub>D</sub>	$d$ $\leq 5.5 V$			0.4	V
VPP power supply voltage	V <sub>PP1</sub>	Normal operation		0		0.6	V
Input leakage current, high	Ілн	$V_{I} = V_{DD} = BV_{DD} =$	EVDD = AVDD			5	μŀ
Input leakage current, low	Lil	$V_{I} = 0 \ V$	V1 = 0 V			-5	μŀ
Output leakage current, high	Ігон	Vo = Vdd = BVdd =	EVDD = AVDD			5	μŀ
Output leakage current, low	ILOL	Vo = 0 V				-5	μ

**Notes 1.** Ports 4, 5, 6, 9, and their alternate-function pins

2. P11, P14, P21, P24, P34, P35, P110 to P113, and their alternate-function pins

**3.** P00 to P07, P10, P12, P13, P15, P20, P22, P23, P25 to P27, P30 to P33, P36, P37, P100 to P107, and their alternate-function pins

4. Ports 7, 8, and their alternate-function pins

#### DC Characteristics (TA = -40 to +85 °C, VDD = 4.0 to 5.5 V, BVDD = EVDD = 3.0 to 5.5 V,

AV<sub>DD</sub> = 4.5 to 5.5 V (when A/D converter is used),

AVDD = 4.0 to 5.5 V (when A/D converter is not used), Vss = AVss = BVss = EVss = 0 V) (2/2)

Para	ameter	Symbol		Conditions	MIN.	TYP.	MAX.	Unit
Supply current	μPD703032A,	IDD1	In normal o	peration mode <sup>Note 1</sup>		25	40	mA
	μPD703032AY	IDD2	In HALT mo	In HALT mode <sup>Note 1</sup>		10	20	mA
		Іддз	In IDLE mode <sup>Note 2</sup>	Watch timer operating		1	4	mA
		IDD4	In STOP mode	Watch timer, subclock oscillator operating		13	70	μA
				Subclock oscillator stopped, XT1 = Vss		8	70	μA
		Idd5	In normal operation mode (subclock operation) <sup>Note 3</sup>			50	150	μA
		IDD6	In IDLE mo		13	70	μA	
	μPD70F3032A,	IDD1	In normal o		42	70	mA	
	μPD70F3032AY	IDD2	In HALT mo	de <sup>Note 1</sup>		14	28	mA
		Idd3	In IDLE mode <sup>Note 2</sup>	Watch timer operating		1	4	mA
		IDD4	In STOP mode	Watch timer, subclock oscillator operating		13	100	μA
				Subclock oscillator stopped, XT1 = Vss		8	100	μA
		Idd5		In normal operation mode (subclock operation) <sup>Note 3</sup>		300	900	μA
		IDD6	In IDLE mode (subclock operation) <sup>Note 3</sup>			170	340	μA
Pull-up resistand	ce	R∟	VIN = 0 V		10	30	100	kΩ

**Notes 1.**  $f_{CPU} = f_{XX} = 20 \text{ MHz}$ , all peripheral functions operating

**2.** fxx = 20 MHz

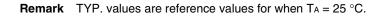
**3.** fcPU = fxT = 32.768 kHz, main clock oscillator stopped

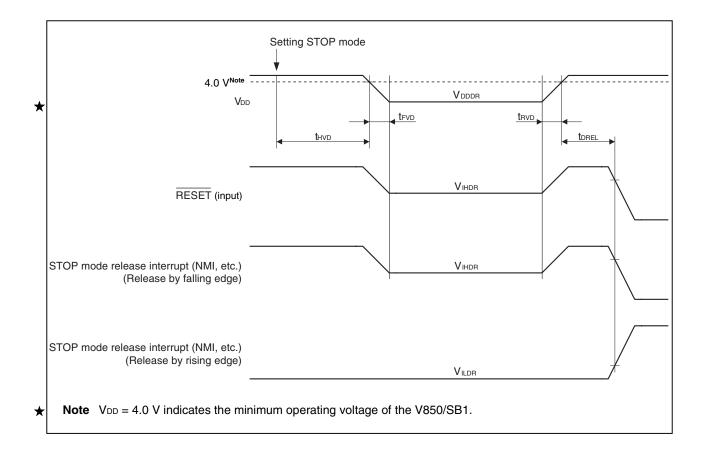
**Remark** TYP. values are reference values for when T<sub>A</sub> = 25 °C, V<sub>DD</sub> = BV<sub>DD</sub> = EV<sub>DD</sub> = AV<sub>DD</sub> = 5.0 V. The current consumed by the output buffer is not included.

#### Data Retention Characteristics (TA = -40 to +85 °C, Vss = AVss = BVss = EVss = 0 V)

	Parameter	Symbol	Со	Conditions		TYP.	MAX.	Unit
*	Data retention voltage	Vdddr	STOP mode (a operating)	STOP mode (all functions not operating)			5.5	V
	Data retention current	Idddr	V <sub>DD</sub> = V <sub>DDDR</sub> , μPD703032A, XT1 = Vss μPD703032AY			8	70	μΑ
			(Subclock stopped)	μPD70F3032A, μPD70F3032AY		8	100	μA
	Power supply voltage rise time	<b>t</b> RVD			200			μs
j	Power supply voltage fall time	tevd			200			μs
	Power supply voltage hold time (from STOP mode setting)	thvd			0			ms
	STOP mode release signal input time	<b>t</b> DREL			0			ms
	Data retention high-level input voltage	VIHDR	All input ports		0.9VDDDR		VDDDR	V
	Data retention low-level input voltage	VILDR	All input ports		0		0.1Vdddr	V

**Note** During STOP mode (when only watch timer is operating),  $V_{DD} = 3.5$  to 5.5 V. Shifting to STOP mode or restoring from STOP mode must be performed at  $V_{DD} = 4.0$  V min.





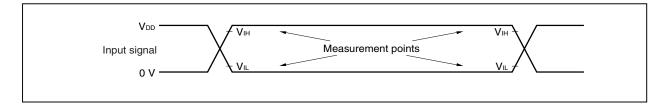
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AC Characteristics (T<sub>A</sub> = -40 to +85 °C, V<sub>DD</sub> = 4.0 to 5.5 V, BV<sub>DD</sub> = EV<sub>DD</sub> = 3.0 to 5.5 V,

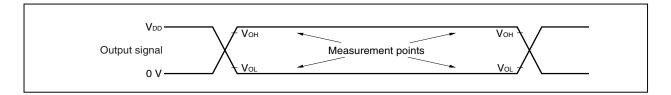
AVDD = 4.5 to 5.5 V (when A/D converter is used),

AV<sub>DD</sub> = 4.0 to 5.5 V (when A/D converter is not used), Vss = AV<sub>SS</sub> = BV<sub>SS</sub> = EV<sub>SS</sub> = 0 V)

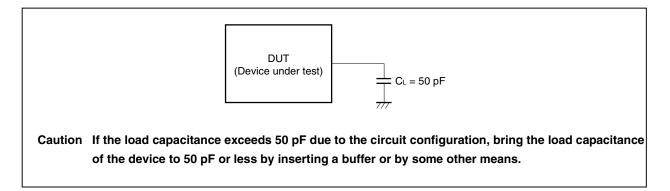
AC Test Input Test Point (VDD: EVDD, BVDD, AVDD)



AC Test Output Test Points (VDD: EVDD, BVDD)



#### Load Conditions



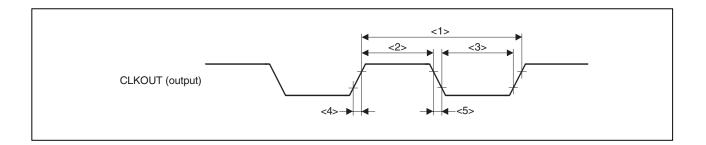
#### (1) Clock timing

#### (a) $T_A = -40$ to +85 °C, $V_{DD} = BV_{DD} = 4.0$ to 5.5 V, $EV_{DD} = 3.0$ to 5.5 V, $V_{SS} = AV_{SS} = BV_{SS} = EV_{SS} = 0$ V

Parameter	Syr	nbol	Conditions	MIN.	MAX.	Unit
CLKOUT output cycle	<1>	tсүк		50 ns	31.2 <i>μ</i> s	
CLKOUT high-level width	<2>	twкн		0.4tсук – 12		ns
CLKOUT low-level width	<3>	twĸ∟		0.4tсук – 12		ns
CLKOUT rise time	<4>	tкв			12	ns
CLKOUT fall time	<5>	tкғ			12	ns

#### (b) $T_A = -40$ to +85 °C, $V_{DD} = 4.0$ to 5.5 V, $BV_{DD} = 3.0$ to 4.0 V, $EV_{DD} = 3.0$ to 5.5 V, $V_{SS} = AV_{SS} = BV_{SS} = EV_{SS} = 0$ V

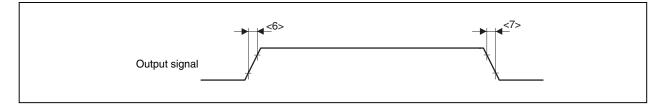
Parameter	Syn	nbol	Conditions	MIN.	MAX.	Unit
CLKOUT output cycle	<1>	tсүк		58.8 ns	31.2 <i>μ</i> s	
CLKOUT high-level width	<2>	twкн		0.4tсук – 15		ns
CLKOUT low-level width	<3>	twĸ∟		0.4tсук – 15		ns
CLKOUT rise time	<4>	<b>t</b> kr			15	ns
CLKOUT fall time	<5>	tкғ			15	ns



(2) Output waveform (other than port 4, port 5, port 6, port 9, and CLKOUT)

#### $(T_A = -40 \text{ to } +85 \text{ °C}, V_{DD} = 4.0 \text{ to } 5.5 \text{ V}, BV_{DD} = EV_{DD} = 3.0 \text{ to } 5.5 \text{ V}, V_{SS} = BV_{SS} = EV_{SS} = 0 \text{ V})$

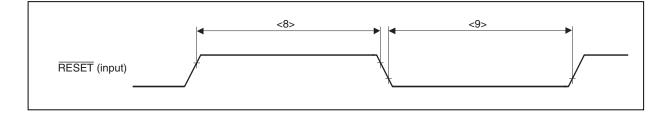
Parameter	Symbol		Conditions	MIN.	MAX.	Unit
Output rise time	<6>	tor			20	ns
Output fall time	<7>	to⊧			20	ns



#### (3) Reset timing

#### (TA = -40 to +85 °C, VDD = 4.0 to 5.5 V, BVDD = EVDD = 3.0 to 5.5 V, Vss = AVss = BVss = EVss = 0 V)

Parameter	Symbol		Conditions	MIN.	MAX.	Unit
RESET pin high-level width	<8>	twrsh		500		ns
RESET pin low-level width	<9>	twrsl		500		ns



#### (4) Bus timing

# (a) Clock asynchronous (T<sub>A</sub> = -40 to +85 °C, V<sub>DD</sub> = BV<sub>DD</sub> = 4.0 to 5.5 V, EV<sub>DD</sub> = 3.0 to 5.5 V, V<sub>SS</sub> = AV<sub>SS</sub> = BV<sub>SS</sub> = EV<sub>SS</sub> = 0 V)

Parameter	Syr	nbol	Conditions	MIN.	MAX.	Unit
Address setup time (to ASTB $\downarrow$ )	<10>	<b>t</b> SAST		0.5T – 16		ns
Address hold time (from ASTB $\downarrow$ )	<11>	tнsта		0.5T – 15		ns
Address float delay time from $\overline{\text{DSTB}}\downarrow$	<12>	<b>t</b> FDA			0	ns
Data input setup time from address	<13>	tsaid			(2 + n)T – 40	ns
Data input setup time from $\overline{\text{DSTB}}\downarrow$	<14>	tsdid			(1 + n)T – 40	ns
Delay time from ASTB $\downarrow$ to $\overline{DSTB}\downarrow$	<15>	<b>t</b> DSTD		0.5T – 15		ns
Data input hold time (from $\overline{\text{DSTB}}$ )	<16>	thdid		0		ns
Address output time from DSTB↑	<17>	<b>t</b> dda		(1 + i)T – 15		ns
Delay time from DSTB↑ to ASTB↑	<18>	tDDST1		0.5T – 15		ns
Delay time from $\overline{DSTB}\uparrow$ to $ASTB\downarrow$	<19>	tddst2		(1.5 + i)T – 15		ns
DSTB low-level width	<20>	twol		(1 + n)T – 22		ns
ASTB high-level width	<21>	twsтн		T – 15		ns
Data output time from $\overline{DSTB} \downarrow$	<22>	todod			10	ns
Data output setup time (to $\overline{DSTB}$ )	<23>	tsodd		(1 + n)T – 25		ns
Data output hold time (from $\overline{\text{DSTB}}^{\uparrow}$ )	<24>	thdod		T – 20		ns
WAIT setup time (to address)	<25>	tsawt1	n ≥ 1		1.5T – 40	ns
	<26>	tsawt2	n ≥ 1		(1.5 + n)T – 40	ns
WAIT hold time (from address)	<27>	thawt1	n ≥ 1	(0.5 + n)T		ns
	<28>	thawt2	n ≥ 1	(1.5 + n)T		ns
$\overline{WAIT}$ setup time (to ASTB $\downarrow$ )	<29>	tsstwt1	n ≥ 1		T – 32	ns
	<30>	tsstwt2	n ≥ 1		(1 + n)T – 32	ns
$\overline{WAIT}$ hold time (from ASTB $\downarrow$ )	<31>	tHSTWT1	n ≥ 1	nT		ns
	<32>	tHSTWT2	n ≥ 1	(1 + n)T		ns
HLDRQ high-level width	<33>	twнqн		T + 10		ns
HLDAK low-level width	<34>	twhal		T – 15		ns
Bus output delay time from HLDAK↑	<35>	<b>t</b> DHAC		-6		ns
Delay time from $\overline{HLDRQ}\downarrow$ to $\overline{HLDAK}\downarrow$	<36>	tDHQHA1			(2n + 7.5)T + 25	ns
Delay time from $\overline{HLDRQ}$ to $\overline{HLDAK}$	<37>	tdhqha2		0.5T	1.5T + 25	ns

**Remarks 1.** T = 1/fcpu (fcpu: CPU operating clock frequency)

2. n: Number of wait clocks inserted in the bus cycle.

- The sampling timing changes when a programmable wait is inserted.
- **3.** i: Number of idle states inserted after a read cycle (0 or 1).
- The values in the above specifications are values for when clocks with a 5:5 duty ratio are input from X1.

Data Sheet U14893EJ2V0DS

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(b) Clock asynchronous (T <sub>A</sub> = -40 to +85 °C, V <sub>DD</sub> = 4.0 to 5.5 V, BV <sub>DD</sub> = 3.0 to 4.0 V, EV <sub>DD</sub> = 3.0 to 5.5 V	,
Vss = AVss = BVss = EVss = 0 V)	

Parameter	Syn	nbol	Conditions	MIN.	MAX.	Unit
Address setup time (to ASTB $\downarrow$ )	<10>	<b>t</b> SAST		0.5T – 20		ns
Address hold time (from ASTB $\downarrow$ )	<11>	<b>t</b> HSTA		0.5T – 22		ns
Address float delay time from $\overline{\text{DSTB}}\downarrow$	<12>	tfda			0	ns
Data input setup time from address	<13>	<b>t</b> SAID			(2 + n)T – 50	ns
Data input setup time from $\overline{\text{DSTB}}\downarrow$	<14>	tsdid			(1 + n)T – 50	ns
Delay time from ASTB $\downarrow$ to $\overline{\text{DSTB}}\downarrow$	<15>	<b>t</b> DSTD		0.5T – 15		ns
Data input hold time (from $\overline{\text{DSTB}}$ )	<16>	thdid		0		ns
Address output time from $\overline{\text{DSTB}}^{\uparrow}$	<17>	tdda		(1 + i)T – 15		ns
Delay time from $\overline{DSTB}^\uparrow$ to $ASTB^\uparrow$	<18>	tDDST1		0.5T – 15		ns
Delay time from $\overline{DSTB}\uparrow$ to $ASTB\downarrow$	<19>	tDDST2		(1.5 + i)T – 15		ns
DSTB low-level width	<20>	twol		(1 + n)T – 35		ns
ASTB high-level width	<21>	twsтн		T – 15		ns
Data output time from $\overline{DSTB} \downarrow$	<22>	tddod			10	ns
Data output setup time (to $\overline{\text{DSTB}}$ )	<23>	tsodd		(1 + n)T – 35		ns
Data output hold time (from $\overline{\text{DSTB}}^{\uparrow}$ )	<24>	<b>t</b> hdod		T – 25		ns
WAIT setup time (to address)	<25>	tsawt1	n ≥ 1		1.5T – 55	ns
	<26>	tsawt2	n ≥ 1		(1.5 + n)T – 55	ns
WAIT hold time (from address)	<27>	<b>t</b> HAWT1	n ≥ 1	(0.5 + n)T		ns
	<28>	thawt2	n ≥ 1	(1.5 + n)T		ns
$\overline{WAIT}$ setup time (to ASTB $\downarrow$ )	<29>	tsstwt1	n ≥ 1		T – 45	ns
	<30>	tsstwt2	n ≥ 1		(1 + n)T – 45	ns
$\overline{WAIT}$ hold time (from ASTB $\downarrow$ )	<31>	tHSTWT1	n ≥ 1	nT		ns
	<32>	tHSTWT2	n ≥ 1	(1 + n)T		ns
HLDRQ high-level width	<33>	twнqн		T + 10		ns
HLDAK low-level width	<34>	<b>t</b> WHAL		T – 25		ns
Bus output delay time from $\overline{\text{HLDAK}}$	<35>	<b>t</b> DHAC		-6		ns
Delay time from $\overline{\text{HLDRQ}}\downarrow$ to $\overline{\text{HLDAK}}\downarrow$	<36>				(2n + 7.5)T + 25	ns
Delay time from $\overline{HLDRQ}$ to $\overline{HLDAK}$	<37>	tdhqha2		0.5T	1.5T + 25	ns

**Remarks 1.** T = 1/fcpu (fcpu: CPU operating clock frequency)

2. n: Number of wait clocks inserted in the bus cycle.

The sampling timing changes when a programmable wait is inserted.

- **3.** i: Number of idle states inserted after a read cycle (0 or 1).
- **4.** The values in the above specifications are values for when clocks with a 5:5 duty ratio are input from X1.

Data Sheet U14893EJ2V0DS

Parameter	Syn	nbol	Conditions	MIN.	MAX.	Unit
Delay time from CLKOUT↑ to address	<38>	<b>t</b> dka		0	19	ns
Delay time from CLKOUT <sup>↑</sup> to address float	<39>	tғка		-12	10	ns
Delay time from CLKOUT $\downarrow$ to ASTB	<40>	<b>t</b> DKST		0	19	ns
Delay time from CLKOUT↑ to DSTB	<41>	tokd		0	19	ns
Data input setup time (to CLKOUT <sup>↑</sup> )	<42>	<b>t</b> sidk		20		ns
Data input hold time (from CLKOUT $\uparrow$ )	<43>	<b>t</b> hkid		5		ns
Data output delay time from CLKOUT↑	<44>	<b>t</b> dkod			19	ns
$\overline{WAIT}$ setup time (to CLKOUT $\downarrow$ )	<45>	tswтк		20		ns
$\overline{WAIT}$ hold time (from CLKOUT $\downarrow$ )	<46>	tнкwт		5		ns
HLDRQ setup time (to CLKOUT↓)	<47>	tsнак		20		ns
HLDRQ hold time (from CLKOUT↓)	<48>	tнкна		5		ns
Delay time from CLKOUT <sup>↑</sup> to address float (during bus hold)	<49>	<b>t</b> dkf			19	ns
Delay time from CLKOUT↑ to HLDAK	<50>	<b>t</b> dkha			19	ns

(c) Clock synchronous (T<sub>A</sub> = -40 to +85 °C, V<sub>DD</sub> = BV<sub>DD</sub> = 4.0 to 5.5 V, EV<sub>DD</sub> = 3.0 to 5.5 V, V<sub>SS</sub> = AV<sub>SS</sub> = BV<sub>SS</sub> = EV<sub>SS</sub> = 0 V)

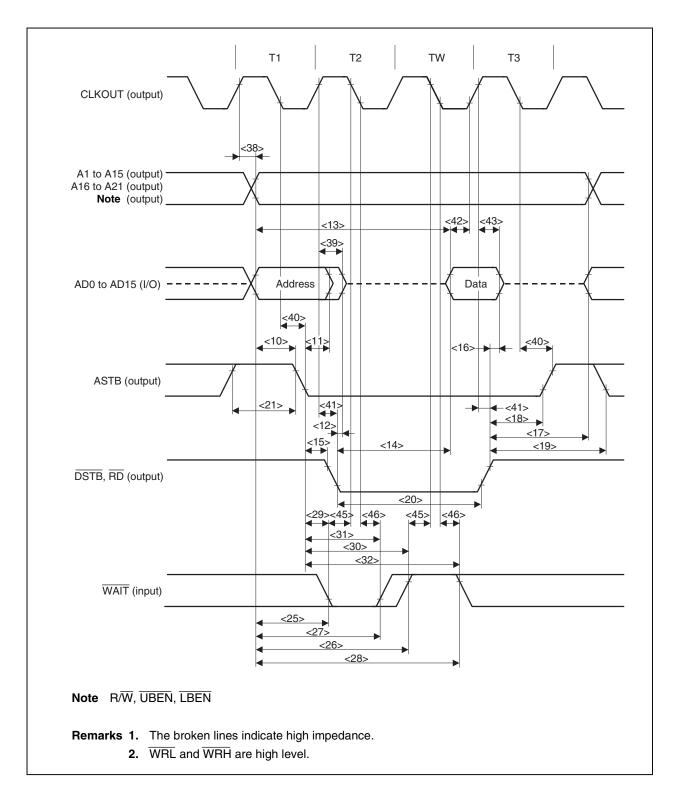
Remark The values in the above specifications are values for when clocks with a 5:5 duty ratio are input from X1.

# (d) Clock synchronous (T<sub>A</sub> = -40 to +85 °C, V<sub>DD</sub> = 4.0 to 5.5 V, BV<sub>DD</sub> = 3.0 to 4.0 V, EV<sub>DD</sub> = 3.0 to 5.5 V, V<sub>SS</sub> = AV<sub>SS</sub> = BV<sub>SS</sub> = EV<sub>SS</sub> = 0 V)

Parameter	Syn	nbol	Conditions	MIN.	MAX.	Unit
Delay time from CLKOUT↑ to address	<38>	<b>t</b> dka		0	22	ns
Delay time from CLKOUT <sup>↑</sup> to address float	<39>	tғка		-16	10	ns
Delay time from CLKOUT $\downarrow$ to ASTB	<40>	<b>t</b> DKST		0	19	ns
Delay time from CLKOUT↑ to DSTB	<41>	tokd		0	22	ns
Data input setup time (to CLKOUT <sup>↑</sup> )	<42>	tsidk		20		ns
Data input hold time (from CLKOUT <sup>↑</sup> )	<43>	<b>t</b> HKID		5		ns
Data output delay time from CLKOUT↑	<44>	<b>t</b> dkod			22	ns
$\overline{WAIT}$ setup time (to CLKOUT $\downarrow$ )	<45>	tswтк		24		ns
$\overline{WAIT}$ hold time (from CLKOUT $\downarrow$ )	<46>	tнкwт		5		ns
HLDRQ setup time (to CLKOUT↓)	<47>	tsнак		24		ns
HLDRQ hold time (from CLKOUT↓)	<48>	tнкна		5		ns
Delay time from CLKOUT <sup>↑</sup> to address float (during bus hold)	<49>	<b>t</b> dkf			19	ns
Delay time from CLKOUT↑ to HLDAK	<50>	<b>t</b> dkha			19	ns

**Remark** The values in the above specifications are values for when clocks with a 5:5 duty ratio are input from X1.

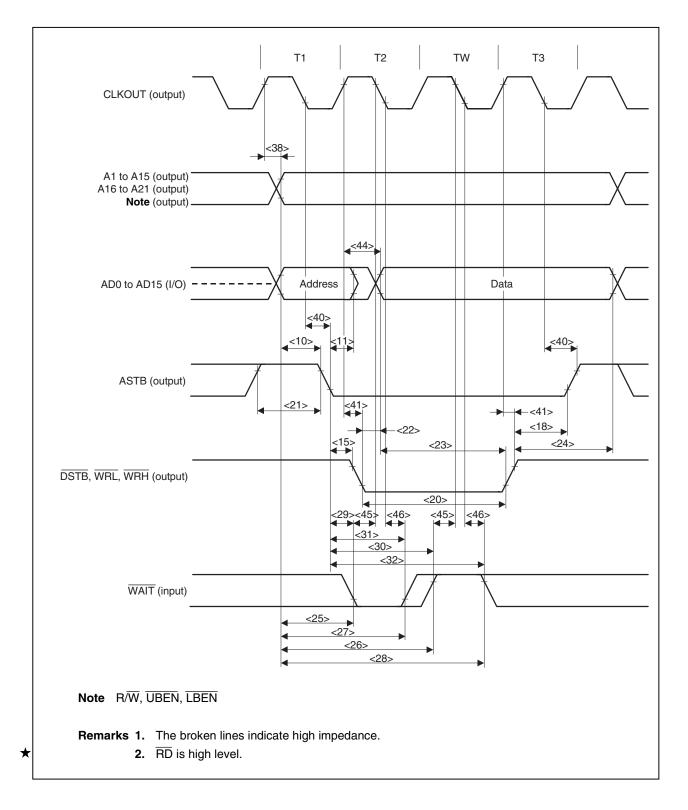
(e) Read cycle (CLKOUT synchronous/asynchronous, 1 wait)



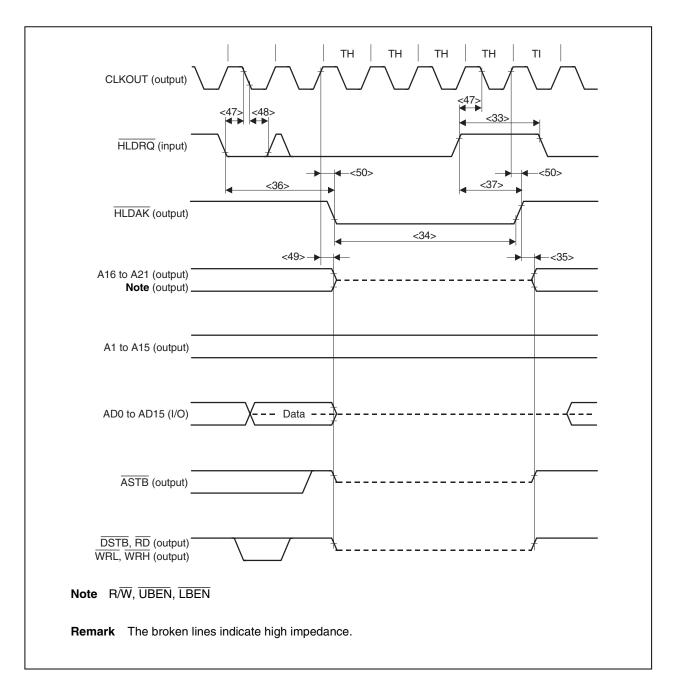
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(f) Write cycle (CLKOUT synchronous/asynchronous, 1 wait)



#### (g) Bus hold timing



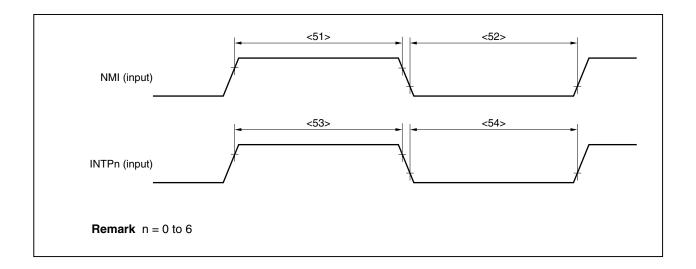
#### (5) Interrupt timing

#### (T<sub>A</sub> = -40 to +85 °C, V<sub>DD</sub> = 4.0 to 5.5 V, BV<sub>DD</sub> = EV<sub>DD</sub> = 3.0 to 5.5 V, V<sub>SS</sub> = AV<sub>SS</sub> = BV<sub>SS</sub> = EV<sub>SS</sub> = 0 V)

Parameter	Syr	nbol	Conditions	MIN.	MAX.	Unit
NMI high-level width	<51>	twniн		500		ns
NMI low-level width	<52>	twnil		500		ns
INTPn high-level width	<53>	twiтн	n = 0 to 3, analog noise elimination	500		ns
			n = 4, 5, digital noise elimination	3T + 20		ns
			n = 6, digital noise elimination	3Tsmp + 20		ns
INTPn low-level width	<54>	twı⊤∟	n = 0 to 3, analog noise elimination	500		ns
			n = 4, 5, digital noise elimination	3T + 20		ns
			n = 6, digital noise elimination	3Tsmp + 20		ns

#### **Remarks 1.** T = 1/fxx

2. Tsmp = Noise elimination sampling clock cycle



## (6) RPU timing

```
(T<sub>A</sub> = -40 to +85 °C, V<sub>DD</sub> = 4.0 to 5.5 V, BV<sub>DD</sub> = EV<sub>DD</sub> = 3.0 to 5.5 V, V<sub>SS</sub> = AV<sub>SS</sub> = BV<sub>SS</sub> = EV<sub>SS</sub> = 0 V)
```

Parameter	Syn	nbol	Conditions	MIN.	MAX.	Unit
TIn0, TIn1 high-level width	<55>	t⊤ıHn	n = 0, 1	2T <sub>sam</sub> + 20 <sup>Note</sup>		ns
TIn0, TIn1 low-level width	<56>	t⊤ILn	n = 0, 1	2Tsam + 20 <sup>Note</sup>		ns
TIm high-level width	<57>	<b>t</b> TIHm	m = 2 to 5	3T + 20		ns
TIm low-level width	<58>	t⊤ı∟m	m = 2 to 5	3T + 20		ns

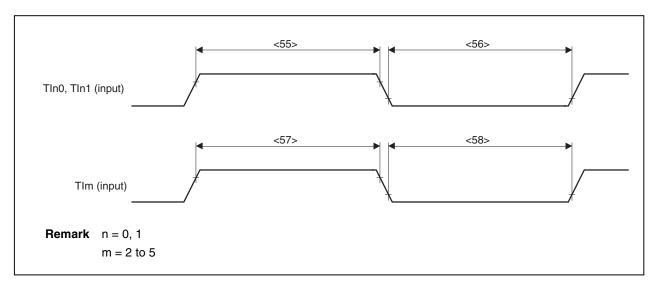
**Note** T<sub>sam</sub> can select the following count clocks by setting the PRMn2 to PRMn0 bits of prescaler mode registers n0, n1 (PRMn0, PRMn1).

When n = 0 (TM0),  $T_{sam} = 2T$ , 4T, 16T, 64T, 256T, or 1/INTWTNI cycle

When n = 1 (TM1), T<sub>sam</sub> = 2T, 4T, 16T, 32T, 128T, or 256T

However, when the TIn0 valid edge is selected as the count clock,  $T_{sam} = 4T$ .

**Remark** T = 1/fxx

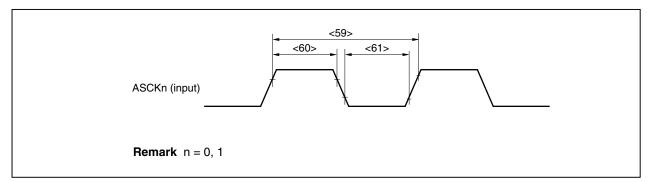


## (7) Asynchronous serial interface (UART0, UART1) timing

(TA = -40 to +85 °C, VDD = 4.0 to 5.5 V, BVDD = EVDD = 3.0 to 5.5 V, Vss = AVss = BVss = EVss = 0 V)

Parameter	Syn	nbol	Conditions	MIN.	MAX.	Unit
ASCKn cycle time	<59>	<b>t</b> ксү13		200		ns
ASCKn high-level width	<60>	<b>t</b> кн13		80		ns
ASCKn low-level width	<61>	tĸ∟13		80		ns

**Remark** n = 0, 1



# (8) 3-wire serial interface (CSI0 to CSI3) timing

#### (a) Master mode

#### (TA = -40 to +85 °C, VDD = 4.0 to 5.5 V, BVDD = EVDD = 3.0 to 5.5 V, Vss = AVss = BVss = EVss = 0 V)

Parameter	Syn	nbol	Conditions	MIN.	MAX.	Unit
SCKn cycle	<62>	tксү1		400		ns
SCKn high-level width	<63>	<b>t</b> кнı		140		ns
SCKn low-level width	<64>	tĸ∟ı		140		ns
SIn setup time (to SCKn↑)	<65>	tsik1		50		ns
SIn hold time (from $\overline{\text{SCKn}}$ )	<66>	tksi1		50		ns
Delay time from $\overline{\operatorname{SCKn}}\downarrow$ to SOn output	<67>	tkso1			60	ns

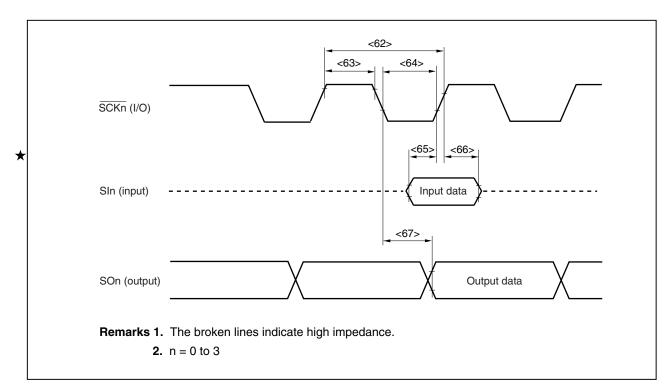
**Remark** n = 0 to 3

#### (b) Slave mode

#### (TA = -40 to +85 °C, VDD = 4.0 to 5.5 V, BVDD = EVDD = 3.0 to 5.5 V, Vss = AVss = BVss = EVss = 0 V)

Parameter	Symbol		Conditions	MIN.	MAX.	Unit
SCKn cycle	<62>	tkCY2		400		ns
SCKn high-level width	<63>	tкн2		140		ns
SCKn low-level width	<64>	tĸ∟2		140		ns
SIn setup time (to SCKn↑)	<65>	tsik2		50		ns
SIn hold time (from $\overline{\text{SCKn}}$ )	<66>	tksi2		50		ns
Delay time from $\overline{SCKn} \downarrow$ to SOn output	<67>	tkso2	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$		70	ns
			$3.0~V \leq EV_{\text{DD}} < 4.0~V$		100	ns

#### **Remark** n = 0 to 3



(9) 3-wire variable length serial interface (CSI4) timing

# (a) Master mode

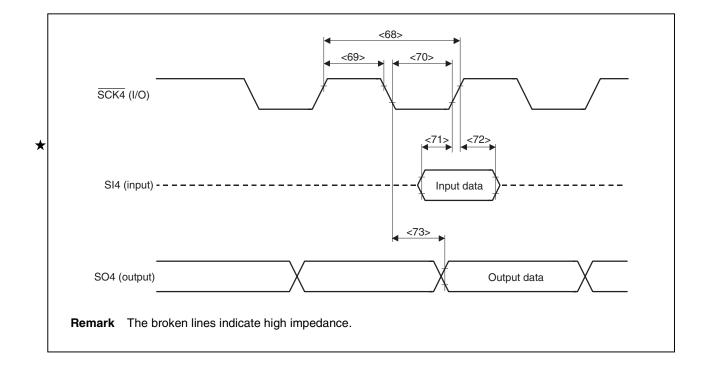
(TA = -40 to +85 °C, VDD = 4.0 to 5.5 V, BVDD = EVDD = 3.0 to 5.5 V, Vss = AVss = BVss = EVss = 0 V)

Parameter	Sy	mbol	Conditions	MIN.	MAX.	Unit
SCK4 cycle	<68>	tkcy1	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	200		ns
			$3.0~V \leq EV_{\text{DD}} < 4.0~V$	400		ns
SCK4 high-level width	<69>	tкн1	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	60		ns
			$3.0~V \leq EV_{\text{DD}} < 4.0~V$	140		ns
SCK4 low-level width	<70>	tĸ∟1	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	60		ns
			$3.0~V \leq EV_{\text{DD}} < 4.0~V$	140		ns
SI4 setup time (to $\overline{\text{SCK4}}$ )	<71>	tsiĸ1	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	25		ns
			$3.0~V \leq EV_{\text{DD}} < 4.0~V$	50		ns
SI4 hold time (from SCK4↑)	<72>	tksi1		20		ns
Delay time from SCK4↓ to SO4 output	<73>	tkso1			55	ns

## (b) Slave mode

 $(T_A = -40 \text{ to } +85 \text{ °C}, V_{DD} = 4.0 \text{ to } 5.5 \text{ V}, BV_{DD} = EV_{DD} = 3.0 \text{ to } 5.5 \text{ V}, V_{SS} = AV_{SS} = BV_{SS} = EV_{SS} = 0 \text{ V})$ 

Parameter	Sy	mbol	Conditions	MIN.	MAX.	Unit
SCK4 cycle	<68>	<b>t</b> ксү2	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	200		ns
			$3.0 \text{ V} \leq \text{EV}_{\text{DD}} < 4.0 \text{ V}$	400		ns
SCK4 high-level width	<69>	tĸH2	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	60		ns
			$3.0 \text{ V} \leq \text{EV}_{\text{DD}} < 4.0 \text{ V}$	140		ns
SCK4 low-level width	<70>	tĸ∟2	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	60		ns
			$3.0 \text{ V} \leq \text{EV}_{\text{DD}} < 4.0 \text{ V}$	140		ns
SI4 setup time (to $\overline{\text{SCK4}}$ )	<71>	tsik2	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$	25		ns
			$3.0 \text{ V} \leq \text{EV}_{\text{DD}} < 4.0 \text{ V}$	50		ns
SI4 hold time (from $\overline{\text{SCK4}}$ )	<72>	tksi2		20		ns
Delay time from $\overline{\text{SCK4}}\downarrow$ to SO4	<73>	tkso2	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$		55	ns
output			$3.0 \text{ V} \leq \text{EV}_{\text{DD}} < 4.0 \text{ V}$		100	ns



# (10) I<sup>2</sup>C bus mode (µPD703032AY, 70F3032AY only)

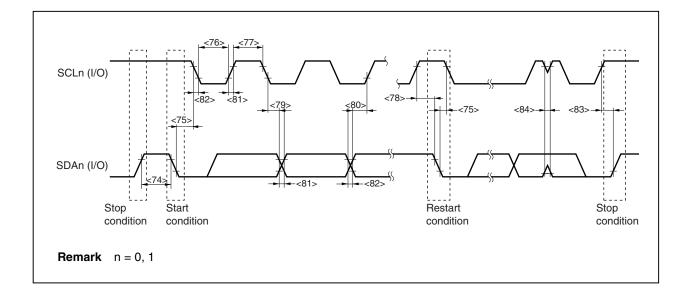
#### (TA = -40 to +85 °C, VDD = 4.0 to 5.5 V, BVDD = EVDD = 3.0 to 5.5 V, Vss = AVss = BVss = EVss = 0 V)

Para	meter	Syr	nbol	Norma	al Mode	High-Spe	ed Mode	Unit
				MIN.	MAX.	MIN.	MAX.	
SCLn clock fre	equency	-	fськ	0	100	0	400	kHz
Bus-free time stop/start cond	•	<74>	tвuғ	4.7	_	1.3	-	μs
Hold time <sup>Note 1</sup>		<75>	thd:sta	4.0	-	0.6	-	μs
SCLn clock lov	w-level width	<76>	tLOW	4.7	-	1.3	-	μs
SCLn clock hi	gh-level width	<77>	tніgн	4.0	-	0.6	-	μs
Setup time for conditions	start/restart	<78>	tsu:sta	4.7	_	0.6	-	μs
Data hold time	CBUS compatible master	<79>	thd:dat	5.0	-	-	_	μs
	I <sup>2</sup> C mode			0 <sup>Note 2</sup>	-	0 <sup>Note 2</sup>	0.9 <sup>Note 3</sup>	μs
Data setup tim	ne	<80>	tsu:dat	250	-	100 <sup>Note 4</sup>	_	ns
SDAn and SC time	Ln signal rise	<81>	t₽	_	1000	20 + 0.1Cb <sup>Note 5</sup>	300	ns
SDAn and SC time	Ln signal fall	<82>	t⊧	_	300	20 + 0.1Cb <sup>Note 5</sup>	300	ns
Stop condition	setup time	<83>	tsu:sto	4.0	-	0.6	_	μs
Pulse width of suppressed by	•	<84>	ts₽	_	_	0	50	ns
Capacitance lo bus line	oad of each		Cb	_	400	-	400	pF

Notes 1. At the start condition, the first clock pulse is generated after the hold time.

- 2. The system requires a minimum of 300 ns hold time internally for the SDAn signal (at VIHmin. of SCLn signal) in order to occupy the undefined area at the falling edge of SCLn.
- If the system does not extend the SCLn signal's low-level width (tLow), only the maximum data hold time (tHD:DAT) needs to be satisfied.
- **4.** The high-speed mode l<sup>2</sup>C bus can be used in the normal-mode l<sup>2</sup>C bus system. In this case, set the high-speed mode l<sup>2</sup>C bus so that it meets the following conditions.
  - If the system does not extend the SCLn signal's low-level width:  $t_{SU:DAT} \ge 250 \text{ ns}$
  - If the system extends the SCLn signal's low-level width:
    - Transmit the following data bit to the SDAn line prior to the SCLn line release ( $t_{Rmax.} + t_{SU:DAT} = 1,000 + 250 = 1,250$  ns: Normal mode l<sup>2</sup>C bus specification).
- 5. Cb: Total capacitance of one bus line (unit: pF)

**Remark** n = 0, 1



Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution	-		10	10	10	bit
Overall error <sup>Note 1</sup>	-	ADM2 = 00H			±0.6	%FSR
		ADM2 = 01H			±1.0	%FSR
Conversion time	<b>t</b> CONV		5		10	μs
Zero-scale error <sup>Note 1</sup>	-				±0.4	%FSR
Full-scale error Note 1	-	ADM2 = 00H			±0.4	%FSR
		ADM2 = 01H			±0.6	%FSR
Integral linearity error Note 2	-	ADM2 = 00H			±4.0	LSB
		ADM2 = 01H			±6.0	LSB
Differential linearity error Note 2	-	ADM2 = 00H			±4.0	LSB
		ADM2 = 01H			±6.0	LSB
Analog reference voltage	AVREF	AVREF = AVDD	4.5		5.5	V
Analog power supply voltage	AVDD		4.5		5.5	V
Analog input voltage	VIAN		AVss		AVREF	V
AVREF input current	AIREF			1	2	mA
AVDD power supply current	Aldd	ADM2 = 00H		3	6	mA
		ADM2 = 01H		4	8	mA

# A/D Converter Characteristics (T<sub>A</sub> = -40 to +85 °C, V<sub>DD</sub> = AV<sub>DD</sub> = AV<sub>REF</sub> = 4.5 to 5.5 V, V<sub>SS</sub> = AV<sub>SS</sub> = 0 V, Output pin load capacitance: $C_L = 50 \text{ pF}$ )

Notes 1. Excluding quantization error (±0.05 %FSR)

- 2. Excluding quantization error (±0.5 LSB)
- Remarks 1. LSB: Least Significant Bit
  - FSR: Full Scale Range
  - 2. ADM2: A/D converter mode register 2

#### Regulator (T<sub>A</sub> = -40 to +85 °C, V<sub>DD</sub> = 4.0 to 5.5 V, V<sub>SS</sub> = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output stabilization time	treg	Stabilization capacitance C = 1 $\mu$ F (Connected to REGC pin)	1			ms

- Cautions 1. Be sure to start inputting supply voltage VDD when RESET = Vss = EVss = BVss = 0 V (the above state), and make RESET high level after the tREG period has elapsed.
  - 2. If supply voltage BV<sub>DD</sub> or EV<sub>DD</sub> is input before the t<sub>REG</sub> period has elapsed following the input of supply voltage V<sub>DD</sub>, note that data may be driven from the pins until the t<sub>REG</sub> period has elapsed because the I/O buffers' power supply was turned on while the circuit was in an undefined state.

# **\star 3.1** Flash Memory Programming Mode ( $\mu$ PD70F3032A, 70F3032AY only)

# Write/erase characteristics (T<sub>A</sub> = -20 to +85 °C, V<sub>DD</sub> = AV<sub>DD</sub> = BV<sub>DD</sub> = EV<sub>DD</sub> = 4.5 to 5.5 V, Vss = AVss = BVss = EVss = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
VPP power supply voltage	Vpp2	During flash memory programming	7.5	7.8	8.1	V
VDD power supply current	ldd	When $V_{PP} = V_{PP2}$ , fxx = 20 MHz			73	mA
VPP power supply current	Ірр	Vpp = Vpp2			100	mA
Step erase time	ter	Note 1		0.2		S
Overall erase time per area	tera	When the step erase time = 0.2 s, <b>Note 2</b>			20	s/area
Write-back time	twв	Note 3		1		ms
Number of write-backs per write-back command	Сwв	When the write-back time = 1 ms, <b>Note 4</b>			300	Count/write- back command
Number of erase/write-backs	Cerwb				16	Count
Step writing time	twn	Note 5		20		μs
Overall writing time per word	twrw	When the step writing time = 20 $\mu$ s (1 word = 4 bytes), Note 6	20		200	μs/word
Number of rewrites per area	Cerwr	1 erase + 1 write after erase = 1 rewrite, <b>Note 7</b>		100		Count/area

Notes 1. The recommended setting value of the step erase time is 0.2 s.

- 2. The prewrite time prior to erasure and the erase verify time (write-back time) are not included.
- 3. The recommended setting value of the write-back time is 1 ms.
- 4. Write-back is executed once by the issuance of the write-back command. Therefore, the retry count must be the maximum value minus the number of commands issued.
- 5. The recommended setting value of the step writing time is 20  $\mu$ s.
- **6.** 20  $\mu$ s is added to the actual writing time per word. The internal verify time during and after the writing is not included.
- 7. When writing initially to shipped products, it is counted as one rewrite for both "erase to write" and "write only".

Example (P: Write, E: Erase)

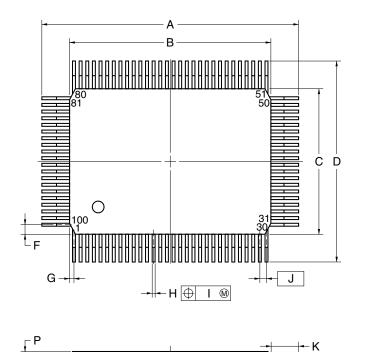
Shipped product  $\longrightarrow P \rightarrow E \rightarrow P \rightarrow E \rightarrow P$ : 3 rewrites Shipped product  $\rightarrow E \rightarrow P \rightarrow E \rightarrow P \rightarrow E \rightarrow P$ : 3 rewrites

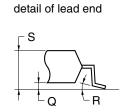
- **Remarks 1.** When the PG-FP3 is used, a time parameter required for writing/erasing by downloading parameter files is automatically set. Do not change the settings unless otherwise specified.
  - 2. Area 0 = 000000H to 01FFFFH Area 2 = 040000H to 05FFFFH Area 1 = 020000H to 03FFFFH Area 3 = 060000H to 07FFFFH

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# 4. PACKAGE DRAWING

# 100-PIN PLASTIC QFP (14x20)





# NOTE

Each lead centerline is located within 0.15 mm of its true position (T.P.) at maximum material condition.

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ITEM	MILLIMETERS
A	23.6±0.4
В	20.0±0.2
С	14.0±0.2
D	17.6±0.4
F	0.8
G	0.6
Н	$0.30 {\pm} 0.10$
I	0.15
J	0.65 (T.P.)
К	1.8±0.2
L	0.8±0.2
М	$0.15\substack{+0.10 \\ -0.05}$
N	0.10
Р	2.7±0.1
Q	0.1±0.1
R	5°±5°
S	3.0 MAX.
P	100GF-65-3BA1-4

# 5. RECOMMENDED SOLDERING CONDITIONS

The  $\mu$ PD703032A, 703032AY, 70F3032A, and 70F3032AY should be soldered and mounted under the following recommended conditions.

For the details of the recommended soldering conditions, refer to the document **Semiconductor Device Mounting Technology Manual (C10535E).** 

For soldering methods and conditions other than those recommended below, contact your NEC sales representative.

#### Table 5-1. Surface Mounting Type Soldering Conditions (1/2)

# (1) μPD703032AGF-xxx-3BA: 100-pin plastic QFP (14 × 20) μPD703032AYGF-xxx-3BA: 100-pin plastic QFP (14 × 20)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235 °C, Time: 30 seconds max. (at 210 °C or higher), Count: Two times or less Exposure limit: 7 days <sup>Note</sup> (after that, prebake at 125 °C for 20 to 72 hours)	IR35-207-2
VPS	Package peak temperature: 215 °C, Time: 25 to 40 seconds (at 200 °C or higher), Count: Two times or less Exposure limit: 7 days <sup>Note</sup> (after that, prebake at 125 °C for 20 to 72 hours)	VP15-207-2
Wave soldering	Solder bath temperature: 260 °C max., Time: 10 seconds max., Count: Once Preheating temperature: 120 °C max. (package surface temperature) Exposure limit: 7 days <sup>Note</sup> (after that, prebake at 125 °C for 20 to 72 hours)	WS60-207-1
Partial heating	Pin temperature: 300 °C max., Time: 3 seconds max. (per pin row)	_

Note After opening the dry pack, store it at 25 °C or less and 65% RH or less for the allowable storage period.

#### Caution Do not use different soldering methods together (except for partial heating).

# Table 5-1. Surface Mounting Type Soldering Conditions (2/2)

# (2) μPD70F3032AGF-3BA: 100-pin plastic QFP (14 × 20) μPD70F3032AYGF-3BA: 100-pin plastic QFP (14 × 20)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235 °C, Time: 30 seconds max. (at 210 °C or higher), Count: Two times or less Exposure limit: 3 days <sup>Note</sup> (after that, prebake at 125 °C for 20 to 72 hours)	IR35-203-2
VPS	Package peak temperature: 215 °C, Time: 25 to 40 seconds (at 200 °C or higher), Count: Two times or less Exposure limit: 3 days <sup>Note</sup> (after that, prebake at 125 °C for 20 to 72 hours)	VP15-203-2
Wave soldering	Solder bath temperature: 260 °C max., Time: 10 seconds max., Count: once Preheating temperature: 120 °C max. (package surface temperature) Exposure limit: 3 days <sup>Note</sup> (after that, prebake at 125 °C for 20 to 72 hours)	WS60-203-1
Partial heating	Pin temperature: 300 °C max., Time: 3 seconds max. (per pin row)	_

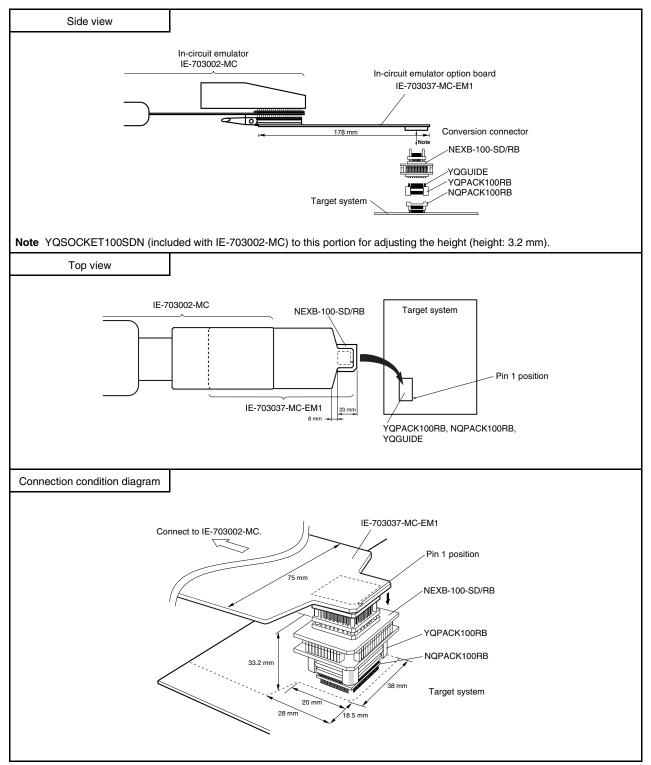
Note After opening the dry pack, store it at 25 °C or less and 65% RH or less for the allowable storage period.

Caution Do not use different soldering methods together (except for partial heating).

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# ★APPENDIX NOTES ON TARGET SYSTEM DESIGN

The following shows a diagram of the connection conditions between the in-circuit emulator option board and conversion connector. Design your system making allowances for conditions such as the form of parts mounted on the target system as shown below.





# NOTES FOR CMOS DEVICES -

# **①** PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

#### Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

# **②** HANDLING OF UNUSED INPUT PINS FOR CMOS

#### Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

## **③** STATUS BEFORE INITIALIZATION OF MOS DEVICES

#### Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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**Related document** μPD703031A, 703031AY, 703033A, 703033AY, 70F3033A, 70F3033AY Data Sheet (U14734E)

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